

FDD4141

#### April 2015

# P-Channel PowerTrench<sup>®</sup> MOSFET -40V, -50A, 12.3m $\Omega$

#### **Features**

- Max  $r_{DS(on)} = 12.3 \text{m}\Omega$  at  $V_{GS} = -10 \text{V}$ ,  $I_D = -12.7 \text{A}$
- Max  $r_{DS(on)} = 18.0 \text{m}\Omega$  at  $V_{GS} = -4.5 \text{V}$ ,  $I_D = -10.4 \text{A}$
- High performance trench technology for extremely low r<sub>DS(on)</sub>
- RoHS Compliant

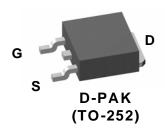
#### **General Description**

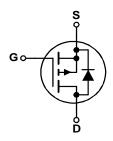
This P-Channel MOSFET has been produced using Fairchild Semiconductor's proprietary PowerTrench® technology to deliver low  $r_{\text{DS(on)}}$  and optimized Bvdss capability to offer superior performance benefit in the applications. and optimized switching performance capability reducing power dissipation losses in converter/inverter applications.

#### **Applications**

- Inverter
- Power Supplies







# MOSFET Maximum Ratings $T_C = 25$ °C unless otherwise noted

Symbol	Parameter			Ratings	Units	
$V_{DS}$	Drain to Source Voltage			-40	V	
$V_{GS}$	Gate to Source Voltage			±20	V	
	Drain Current -Continuous (Package limited)	T <sub>C</sub> = 25°C		-50		
	-Continuous (Silicon limited)	T <sub>C</sub> = 25°C		-58	_	
ID	-Continuous	T <sub>A</sub> = 25°C	(Note 1a)	-10.8	Α	
	-Pulsed			-100		
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	337	mJ	
Б	Power Dissipation	T <sub>C</sub> = 25°C		69	W	
$P_{D}$	Power Dissipation	ower Dissipation $T_A = 25^{\circ}C$ (Note 1a)		2.4	VV	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature R	ange		-55 to +150	°C	

# **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case		1.8	°C/W
R <sub>e.IA</sub>	Thermal Resistance, Junction to Ambient	(Note 1a)	52	C/VV

#### **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity	
FDD4141	FDD4141	D-PAK (TO-252)	13"	16mm	2500 units	

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# **Electrical Characteristics** $T_J = 25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units				
Off Characteristics										
$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-40			V				
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = -250\mu A$ , referenced to 25°C		-29		mV/°C				
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -32V, V_{GS} = 0V$			-1	μΑ				
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA				

#### On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = -250 \mu A$	-1	-1.8	-3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I <sub>D</sub> = -250μA, referenced to 25°C		5.8		mV/°C
	Static Drain to Source On Resistance	$V_{GS} = -10V, I_D = -12.7A$		10.1	12.3	
roce		$V_{GS} = -4.5V, I_D = -10.4A$		14.5	18.0	mΩ
r <sub>DS(on)</sub>		$V_{GS} = -10V, I_D = -12.7A,$ $T_J = 125$ °C		15.3	18.7	- 11122
g <sub>FS</sub>	Forward Transconductance	$V_{DS} = -5V, I_{D} = -12.7A$		38		S

#### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	$V_{DS} = -20V, V_{GS} = 0V,$ $f = 1MHz$ $f = 1MHz$	2085	2775	pF
C <sub>oss</sub>	Output Capacitance		360	480	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1101112	210	310	pF
$R_g$	Gate Resistance	f = 1MHz	4.6		Ω

### **Switching Characteristics**

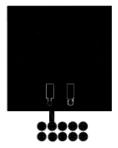
t <sub>d(on)</sub>	Turn-On Delay Time	.,	10	19	ns
t <sub>r</sub>	Rise Time	$V_{DD} = -20V, I_{D} = -12.7A,$ $V_{GS} = -10V, R_{GEN} = 6\Omega$	7	13	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>GS</sub> = -10V, K <sub>GEN</sub> = 012	38	60	ns
t <sub>f</sub>	Fall Time		15	27	ns
$Q_g$	Total Gate Charge	V <sub>GS</sub> = 0V to -10V	36	50	nC
$Q_g$	Total Gate Charge	$V_{GS} = 0V \text{ to -}10V$ $V_{GS} = 0V \text{ to -}5V$ $V_{DD} = -20V,$ $I_{D} = -12.7A$	19	27	nC
$Q_{gs}$	Gate to Source Charge	I <sub>D</sub> = -12.7A	7		nC
$Q_{gd}$	Gate to Drain "Miller" Charge		8		nC

#### **Drain-Source Diode Characteristics**

$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_S = -12.7A$ (Note 2)	-0.8	-1.2	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = -12.7A, di/dt = 100A/μs	29	44	ns
Q <sub>rr</sub>	Reverse Recovery Charge		26	40	nC

Re<sub>0,D</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.

R<sub>0,D</sub> is guaranteed by design while R<sub>0,D</sub> is determined by the user's board design.



a) 52°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b) 100°C/W when mounted on a minimum pad.

- 2: Pulse Test: Pulse Width < 300 $\mu$ s, Duty cycle < 2.0%. 3: Starting T<sub>J</sub> = 25°C, L = 3mH, I<sub>AS</sub> = 15A, V<sub>DD</sub> = 40V, V<sub>GS</sub> = 10V.

## Typical Characteristics T<sub>J</sub> = 25°C unless otherwise noted

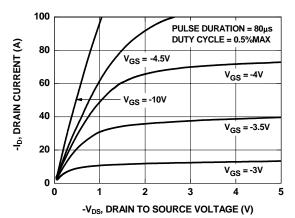


Figure 1. On-Region Characteristics

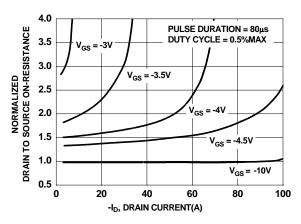


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

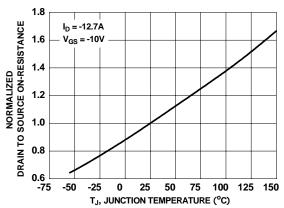


Figure 3. Normalized On-Resistance vs Junction Temperature

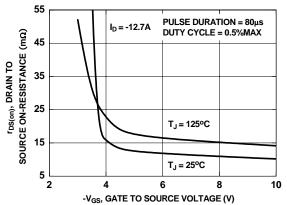


Figure 4. On-Resistance vs Gate to Source Voltage

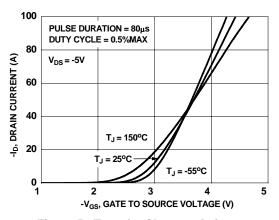


Figure 5. Transfer Characteristics

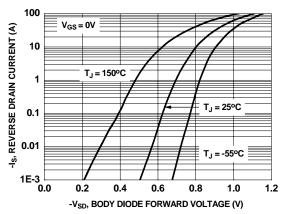


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

# Typical Characteristics T<sub>J</sub> = 25°C unless otherwise noted

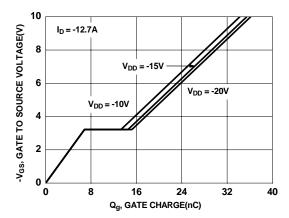


Figure 7. Gate Charge Characteristics

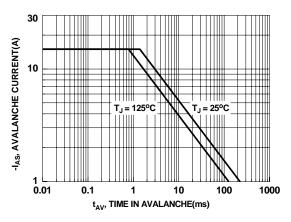


Figure 9. Unclamped Inductive Switching Capability

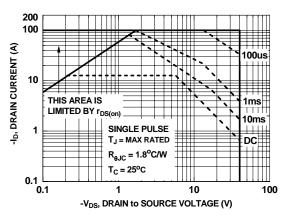


Figure 11. Forward Bias Safe Operating Area

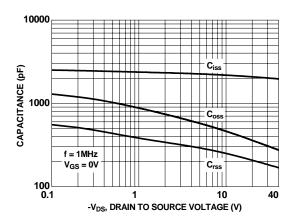


Figure 8. Capacitance vs Drain to Source Voltage

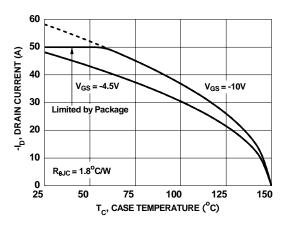


Figure 10. Maximum Continuous Drain Current vs Case Temperature

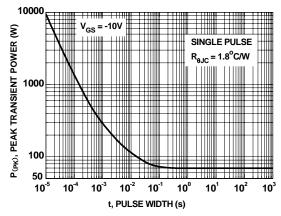


Figure 12. Single Pulse Maximum Power Dissipation

# **Typical Characteristics** T<sub>J</sub> = 25°C unless otherwise noted

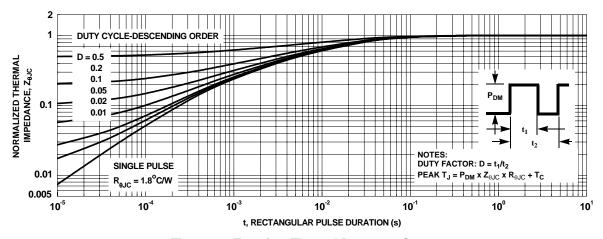
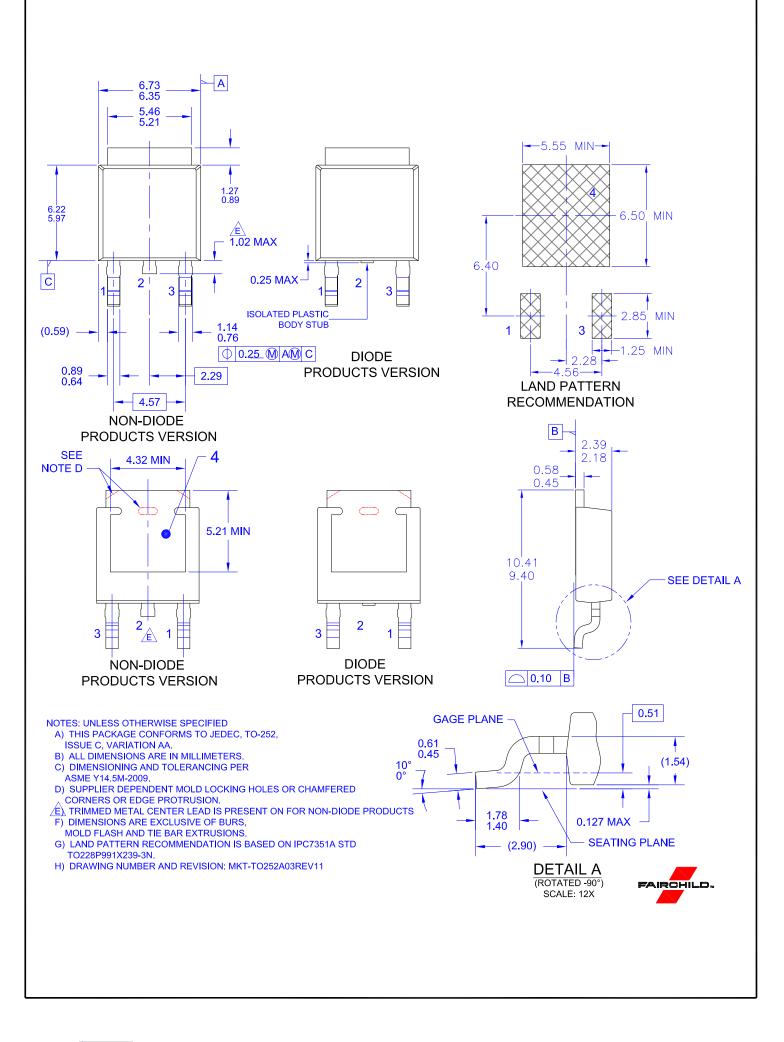


Figure 13. Transient Thermal Response Curve



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